

**Search Notes**

Application/Control No.

10/500,717

Examiner

DINH T. LE

Applicant(s)/Patent under  
Reexamination

TAKAHASHI, AKIRA

Art Unit

2816

**SEARCHED**

Class	Subclass	Date	Examiner
327	99, 144- 147, 156- 158	12/22/2005	DL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
327	see above	12/22/2005	DL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (Attached a serach copy)	12/22/2005	DL